


<b>Search Notes</b>  	<b>Application/Control No.</b>  10520876	<b>Applicant(s)/Patent Under Reexamination</b>  SCHUIJERS ET AL.
	<b>Examiner</b>  BRIAN L ALBERTALLI	<b>Art Unit</b>  2626

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
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EAST Search - See search history printout	4/25/08	BA
IEEE Search - Search Terms: LPC, temporal envelope, linear prediction, frequency domain, FFT	4/25/08	BA
INSPEC Search - Search Terms: LPC, temporal envelope, linear prediction, frequency domain, FFT	4/25/08	BA
Updated EAST Search - see search history printout	11/12/08	BA

INTERFERENCE SEARCH			
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